

10/573320

PTO/SB/08A (07-05)

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Complete if Known

Substitute for form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT(S)	Application Number	Unknown
	Filing Date	Herewith
	First Named Inventor	Patrick J. Brennan et al.
	Art Unit	Unknown
	Examiner Name	Unknown
Sheet 1 of 3	Attorney Docket No.	QPCZ 2 00041 US

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Examiner Initials*	Cite No.	Document No. Number-Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
R	AA	US-1,827,530	10/13/1931	Le Grand
R	AB	US-3,488,681	01/06/1970	Mita et al.
R	AC	US-3,886,791	06/03/1975	Grossman
R	AD	US-4,012,954	03/22/1977	Klippert
R	AE	US-4,698,507	10/06/1987	Tator et al.
R	AF	US-4,817,447	04/04/1989	Kashima et al.
R	AG	US-4,874,952	10/17/1989	Arnaud et al.
R	AH	US-4,995,273	02/26/1991	Kisima et al.
R	AI	US-5,206,518	04/27/1993	Fedor et al.
R	AJ	US-5,476,636	12/19/1995	Tomiita et al.
R	AK	US-5,646,358	07/08/1997	Tikhtman et al.
R	AL	US-5,998,799	12/07/1999	Cremer et al.

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	AN				<input type="checkbox"/>
	AO				<input type="checkbox"/>
	AP				<input type="checkbox"/>

OTHER - NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume/issue number(s), publisher, city and/or country where published	T
R	AQ	International Search Report corresponding to PCT/US2004/006123	<input type="checkbox"/>
R	AR	Ulrich Schulz, Peter Trubiroha, Theodor Engbert and Thomas Klimmasch, "The environmental etch resistance of high-quality PU clear coats", ECJ 1-2/99	<input type="checkbox"/>
R	AS	Weiss Technik, "Weathering Tests, Global-UV-Test Unit, Model UV200, System Weiss - Type BAM", March 2000	<input type="checkbox"/>
R	AT	B.-J. Schniewind, Reiskirchen, "Weathering Tests using Fluorescent Lamps as Radiation Sources" Translated from Kunststoffe 78 (1988) 11, pp. 1085/1088	<input type="checkbox"/>

Examiner Signature	RA EVIS	Date Considered	8/22/07
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	Application Number	Unknown
	Filing Date	Herewith
	First Named Inventor	Patrick J. Brennan et al.
	Art Unit	Unknown
	Examiner Name	Unknown
Sheet 2 of 3	Attorney Docket No.	QPCZ 2 00041 US

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Examiner Initials*	Cite No.	Document No. Number-Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
R	BA	US-6,285,137	09/04/2001	Grossman et al.
R	BB	US-6,525,493	02/25/2003	Grossman et al.
	BC	US-		
	BD	US-		
	BE	US-		
	BF	US-		
	BG	US-		
	BH	US-		
	BI	US-		
	BJ	US-		
	BK	US-		
	BL	US-		

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	BM				<input type="checkbox"/>
	BN				<input type="checkbox"/>
	BO				<input type="checkbox"/>
	BP				<input type="checkbox"/>

OTHER - NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume/issue number(s), publisher, city and/or country where published	T
R	BQ	Ulrich Schulz and Peter Trubiroha, "Predicting Water Spot and Acid Etch Resistance of Clearcoats by Artificial Weathering: Acid Dew and Fog Test", pp. 106-120	<input type="checkbox"/>
R	BR	Atlas Electric Devices Company, "XR35 Extreme Climate Accelerated Weathering"	<input type="checkbox"/>
R	BS	Magnus Palm and Bo Carlsson, "New Accelerated Weathering Tests Including Acid Rain", Journal of Coatings Technology, Vol. 74, No. 924, January 2002, pp. 69-74	<input type="checkbox"/>

Examiner Signature	RA2V13	Date Considered	9/22/07
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Substitute for form 1449/PTO			Complete if Known		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT(S)			Application Number	Unknown	
			Filing Date	Herewith	
			First Named Inventor	Patrick J. Brennan et al.	
			Art Unit	Unknown	
			Examiner Name	Unknown	
Sheet 3 of 3			Attorney Docket No.	QPCZ 2 00041 US	
U.S. PATENT DOCUMENTS					
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	CB	US-			
	CC	US-			
	CD	US-			
	CE	US-			
	CF	US-			
	CG	US-			
	CH	US-			
	CI	US-			
	CJ	US-			
	CK	US-			
	CL	US-			
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	CN				<input type="checkbox"/>
	CO				<input type="checkbox"/>
	CP				<input type="checkbox"/>
OTHER - NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published			T
R	CQ	Heraeus, "XENOTEST® 250T Accelerated light exposure and weathering machine Operating instructions", pp. 1-24			<input type="checkbox"/>
R	CR	QUV Accelerated Weathering Tester Bulletin L8060 "Horizontal Option with ponding & water spray"			<input type="checkbox"/>
	CS				<input type="checkbox"/>
	CT				<input type="checkbox"/>

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Substitute for form 1449/PTO JUL 12 2006 INFORMATION DISCLOSURE STATEMENT BY APPLICANT(S)	Complete if Known	
	Application Number	10/573,320
	Filing Date	March 24, 2006
	First Named Inventor	Patrick J. Brennan et al.
	Art Unit	Unknown
	Examiner Name	Unknown
Sheet 1 of 1	Attorney Docket No.	QPCZ 2 00041 US

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	AI			
	AJ			
	AK			
	AL			

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	AN				<input type="checkbox"/>
	AO				<input type="checkbox"/>
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R	AQ	"Accelerated Light and Weather Exposure Test," System Weiss, Weiss Technik, Global-UV-Test Unit; Model BAM, 2 pages, D-Nr. TP 0.0.6 E / 165892-165894, Germany	<input type="checkbox"/>
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	AS		<input type="checkbox"/>
	AT		<input type="checkbox"/>

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